

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/672,498	YAMAGUCHI, AKIRA	
		Examiner	Art Unit	Page 1 of 1
		Don P Le	2819	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,646,472	11-2003	Trivedi et al.	326/93
	B	US-6,246,266	06-2001	Bosshart, Patrick W.	326/98
	C	US-6,208,170	03-2001	Iwaki et al.	326/121
	D	US-6,124,737	09-2000	Lan et al.	326/121
	E	US-6,111,434	08-2000	Ciraula et al.	326/98
	F	US-6,078,195	06-2000	Chen, Wei	326/121
	G	US-5,982,199	11-1999	Yu, Larry S.	326/121
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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